## Notice of References Cited Application/Control No. 10/037,422 Examiner Khanh Tran Applicant(s)/Patent Under Reexamination NIECZYPOROWICZ ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,432,814	07-1995	Hasegawa, Takaaki	375/133
	В	US-6,108,369	08-2000	Ovesjo et al.	375/146
	С	US-6,795,689	09-2004	Ogren et al.	455/67.13
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-	_		
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		-			
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	x	

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